Applicant(s)/Patent Under Application/Control No. Reexamination 10/775,668 MACK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2609 **Helene Tayong U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 375/130 US-6,115,411 09-2000 van Driest, Hans Α 375/363 US-6,727,790 04-2004 В Raphaeli et al. US-5216693 44-4994 Nakamura Masaru 375/1 С 455/2 US-6035177 02-1996 Moses et al. Đ US-US-F US-G USн US-US-Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 0 Q R S **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) w

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х